## Notice of References Cited

Application/Control No. 10/755,032	Applicant(s)/Patent Under Reexamination IKENO, HIDEO		
Examiner	Art Unit		
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,146,412	12-2006	Turnbull, Paul F.	709/220
*	В	US-2002/0129107	09-2002	Loughran et al.	709/206
*	С	US-2002/0099782	07-2002	Bando et al.	709/206
*	D	US-7,065,560	06-2006	Erickson et al.	709/219
*	Е	US-2003/0135613	07-2003	Yoshida et al.	709/224
*	F	US-2003/0086122	05-2003	Parry, Travis J.	358/402
*	G	US-2006/0244986	11-2006	Ferlitsch, Andrew R.	358/001.13
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		1			
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*	NON-FAIGHT DOCUMENTS			
		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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